Search Notes		Application No. 10/050,378		Applicant(s) CHANG ET AL.	
		Examiner V. Paul Harper		Art Unit 2654	

SEARCHED			
Class	Subclass	Date	Examiner
704	200 231 233*	1/12/05	UPH
	258		
	260		
	275		
379	88.16		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Searched EAST (Attached) PLUS, WEEW, Inventor search Performed	1/12/05	UPH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

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